Product data sheet

1. General description

WG25N120MAW1 uses advanced Fine Trench Field-stop IGBT technology with antiparallel diode in TO247 package. This device is part of the Medium speed series of IGBTs, which represents an optimum compromise between conduction and switching losses to maximize the efficiency of high switching frequency converter.



2. Features and benefits

- Maximum junction temperature 175°C
- · Medium switching speed
- · Positive Temperature efficient for Easy Parallel Operating
- · Very soft, fast recovery anti-parallel diode
- · EMI Improve Design

3. Applications

- Solar inverter
- UPS
- · Welding converters
- PFC
- · Mid to high switching frequency applications

4. Quick reference data

Table 1. Quick reference data

Symbol	Parameter	arameter			Value		Unit		
V _{CE}	Collector-emitter voltage, T _j ≥ 25 °C				1200		V		
I _C	DC collector current, limited by $T_{j(max)}$ $T_C = 100 ^{\circ}C$				25		Α		
Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit		
Static characteristics									
V _{CE(sat)}	Collector-emitter saturation voltage	$V_{GE} = 15 \text{ V}; I_{C} = 25 \text{ A}; T_{j} = 25 \text{ °C}$		-	1.65	2.15	V		

5. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		•C
2	С	collector		
3	Е	emitter		
mb	С	mounting base; connected to collector	TO247	G E sym200

6. Ordering information

Table 3. Ordering information

Type number	Package Name	Orderable part number	Packing method	Small packing quantity	Package version	Package issue date
WG25N120MAW1	TO247	WG25N120MAW1Q	Tube	30	TO247P	09-Mar-2023

7. Marking

Table 4. Marking codes

Type number	Marking codes
WG25N120MAW1	G25N120 MAW1

8. Limiting values

Table 5. Limiting values

Symbol	Parameter	Notes	Value	Unit
V _{CE}	Collector-emitter voltage, T _j ≥ 25 °C		1200	V
I _c	DC collector current, limited by $T_{j(max)}$ $T_c = 25 ^{\circ}C$ $T_c = 100 ^{\circ}C$		50 25	А
I _{C(puls)}	Pulsed collector current, t _p limited by T _{j(max)}		75	Α
-	Turn off safe operating area $V_{CE} \le 1200 \text{ V}, T_j \le 175 ^{\circ}\text{C}, t_p = 1 \mu\text{s}$		75	А
I _F	Diode forward current, limited by $T_{j(max)}$ T_{c} = 25 °C T_{c} = 100 °C		24 12	А
I _{Fpuls}	Diode pulsed current, t _p limited by T _{j(max)}		36	Α
V_{GE}	Gate-emitter voltage		±20	V
P _{tot}	Power dissipation $T_C = 25 ^{\circ}\text{C}$ Power dissipation $T_C = 100 ^{\circ}\text{C}$		375 188	W
t _{sc}	Short circuit withstand time $V_{GE} = 15.0 \text{ V}, V_{CC} \le 600 \text{ V}$ Allowed number of short circuits < 1000 Time between short circuits: $\ge 1.0 \text{ s}$ $T_j = 150 ^{\circ}\text{C}$		10	us
T _{stg}	Storage temperature		-55 to +150	°C
T_{jmax}	Maximum operating junction temperature		175	°C
-	Peak soldering temperture		260	°C
М	Mounting Torque with washer		0.55	Nm

9. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
R _{th(j-c)}	IGBT thermal resistance from junction to case			-	0.4	-	K/W
R _{th(j-c)}	Diode thermal resistance from junction to case			-	2.0	-	K/W
R _{th(j-a)}	thermal resistance from junction to ambient			-	40	-	K/W

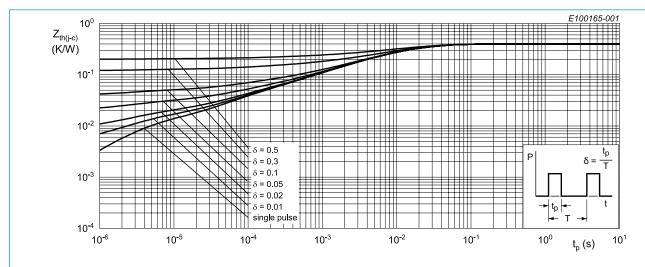


Fig. 1. Transient thermal impedance from junction to case as a function of pulse duration; IGBT

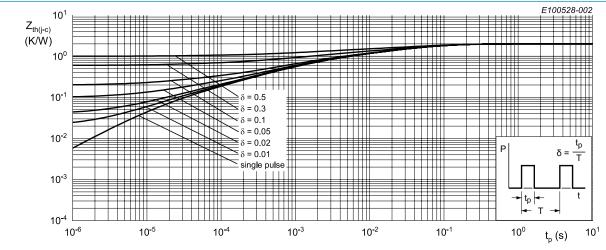


Fig. 2. Transient thermal impedance from junction to case as a function of pulse duration; Diode

10. Characteristics

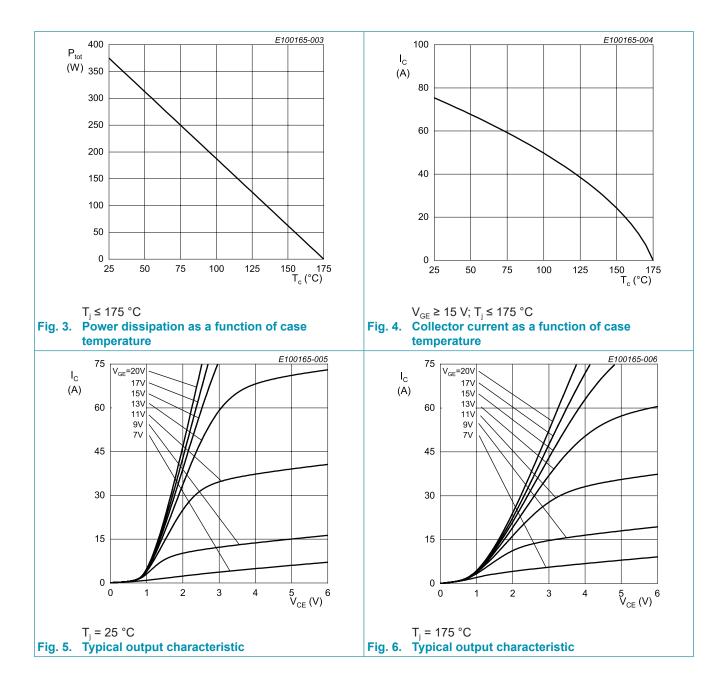
Table 7. Characteristics

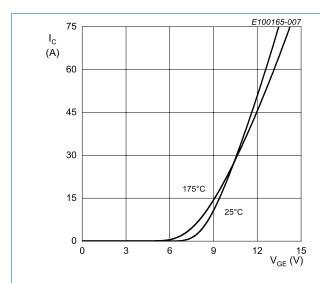
Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
Static cha	racteristics						
BV_CES	Collector-emitter breakdown voltage	$V_{GE} = 0 \text{ V}; I_C = 1 \text{ mA}$		1200	-	-	V
$V_{\text{CE(sat)}}$	Collector-emitter saturation	$V_{GE} = 15 \text{ V}; I_{C} = 25 \text{ A}; T_{j} = 25 \text{ °C}$		-	1.65	2.15	V
	voltage	V_{GE} = 15 V; I_{C} = 25 A; T_{j} = 175 °C		-	2.15	-	V
V _F	Diode forward voltage	$V_{GE} = 0 \text{ V}; I_F = 12 \text{ A}; T_j = 25 \text{ °C}$		-	2.2	-	V
		$V_{GE} = 0 \text{ V}; I_F = 12 \text{ A}; T_j = 175 ^{\circ}\text{C}$		-	2.0	-	V
$V_{\text{GE(th)}}$	Gate-emitter threshold voltage	I_{C} = 250 μ A; V_{CE} = V_{GE}		4.5	5.6	6.7	V
I _{CES}	Zero gate voltage collector current	V_{CE} = 1200 V; V_{GE} = 0 V; T_{j} = 25 °C		-	-	250	μA
		$V_{CE} = 1200 \text{ V}; V_{GE} = 0 \text{ V}; T_j = 175$ °C		-	-	10	mA
g _{fs}	Transconductance	$V_{CE} = 20 \text{ V}; I_{C} = 25 \text{ A}$		-	38	-	S
Dynamic	characteristics						
C _{ies}	Input capacitance	$V_{CE} = 30 \text{ V}; V_{GE} = 0 \text{ V}; f = 1 \text{ MHz};$		-	3240	-	pF
C _{oes}	Output capacitance	$T_j = 25 ^{\circ}\text{C}$		-	53	-	pF
C _{res}	Reverse transfer capacitance			-	28	-	pF
Q_G	Gate charge	V_{CC} = 960 V; I_{C} = 25 A; V_{GE} = 15 V; T_{j} = 25 °C		-	150	-	nC

11. Switching Characteristics

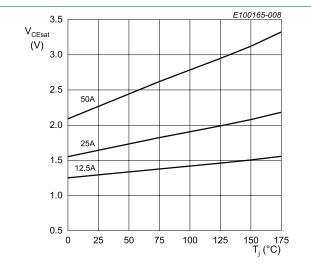
Table 8 Switching Characteristics Inductive Load

Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
IGBT cha	racteristics						
$t_{d(on)}$	Turn-on delay time	T _j = 25 °C;		-	36	-	nS
t _r	Rise time	$T_{j} = 25 ^{\circ}\text{C};$ $V_{CC} = 600 \text{V}; I_{C} = 25 \text{A};$ $V_{GE} = 15 \text{V} / \text{OV};$ $R_{G} = 10 \Omega$ $T_{j} = 175 ^{\circ}\text{C};$ $V_{CC} = 600 \text{V}; I_{C} = 25 \text{A};$ $V_{GE} = 15 \text{V} / \text{OV};$ $R_{G} = 10 \Omega$ $T_{j} = 25 ^{\circ}\text{C};$ $V_{R} = 600 \text{V}; I_{F} = 12 \text{A};$ $dI_{F}/dt = 800 \text{A}/\text{us}$		-	28	-	nS
$t_{\text{d(off)}}$	Turn-off delay time			-	218	-	nS
t _f	Fall time			-	129	-	nS
E _{on}	Turn-on energy			-	1.15	-	mJ
E _{off}	Turn-off energy			-	1.2	-	mJ
E _{ts}	Total switching energy			-	2.35	-	mJ
t _{d(on)}	Turn-on delay time	T _j = 175 °C;		-	35	-	nS
t _r	Rise time	$V_{cc} = 600 \text{ V; } I_{c} = 25 \text{ A;}$ $V_{GE} = 15 \text{ V / } 0 \text{ V;}$ $R_{g} = 10 \Omega$		-	28	-	nS
$t_{d(off)}$	Turn-off delay time			-	262	-	nS
t _f	Fall time			-	226	-	nS
E _{on}	Turn-on energy			-	1.7	-	mJ
E _{off}	Turn-off energy			-	1.85	-	mJ
E _{ts}	Total switching energy			-	3.55	-	mJ
Diode cha	aracteristics				1		
t _{rr}	Reverse recovery time	T _j = 25 °C;		-	55	-	nS
Q _r	Reverse recovery charge			-	565	-	nC
I _{RM}	Reverse recovery peak current			-	19	-	А
t _{rr}	Reverse recovery time	T _j = 175 °C;		-	110	-	nS
Q _r	Reverse recovery charge			-	1200	-	nC
I _{RM}	Reverse recovery peak current			-	23	-	А

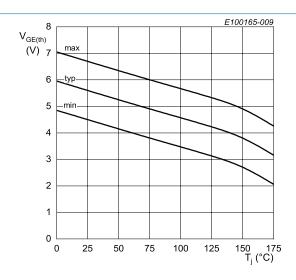




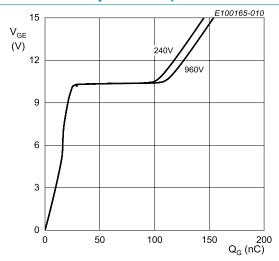
 V_{CE} = 20 V Fig. 7. Typical transfer characteristic



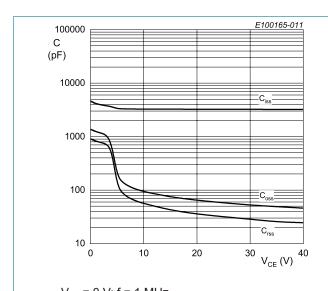
V_{GE} = 15 V
Fig. 8. Typical collector-emitter saturation voltage as a function of junction temperature

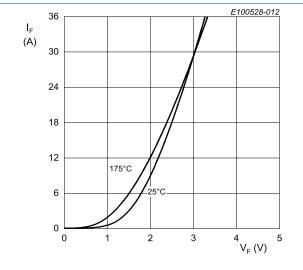


 I_{c} = 250 μA Fig. 9. Gate-emitter threshold voltage as a function of junction temperature



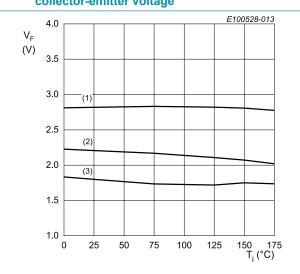
 $I_{\rm C}$ = 25 A Fig. 10. Typical gate charge

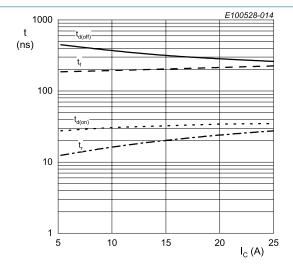




V_{GE} = 0 V; f = 1 MHz
Fig. 11. Typical capacitance as a function of collector-emitter voltage

Fig. 12. Typical diode forward current as a function of forward voltage

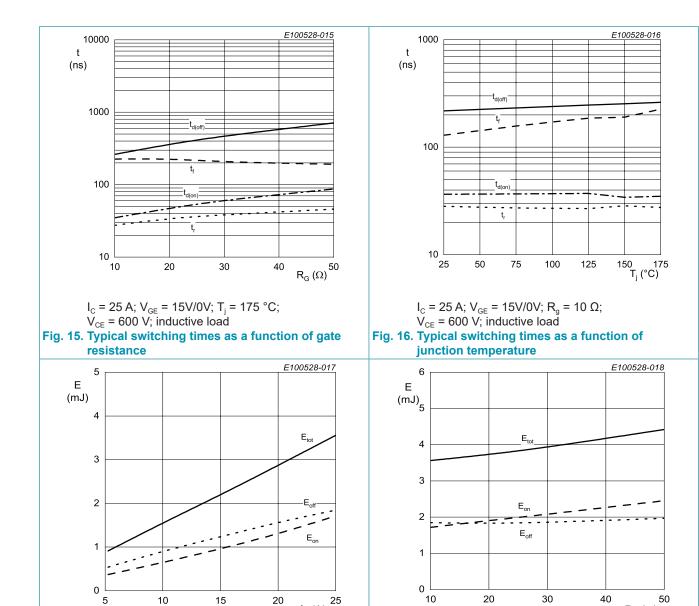




(1) $I_F = 24 A$ (2) $I_F = 12 A$ (3) $I_F = 6 A$ $R_g = 10 \Omega$; $V_{GE} = 15V/0V$; $T_j = 175 ^{\circ}C$; $V_{CE} = 600 V$; inductive load

Fig. 13. Typical diode forward voltage as a function of junction temperature

Fig. 14. Typical switching times as a function of collector current



 $\mathsf{R}_{\mathsf{G}}\left(\Omega\right)$

 $I_C = 25 \text{ A}; V_{GE} = 15 \text{V}/0 \text{V}; T_i = 175 °\text{C};$

Fig. 18. Typical switching energy losses as a function

V_{CE} = 600 V; inductive load

of gate resistance

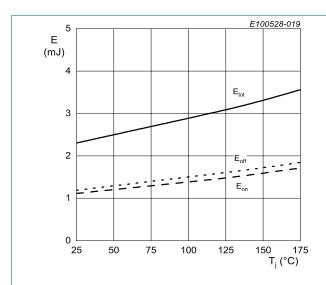
 $I_{C}(A)$

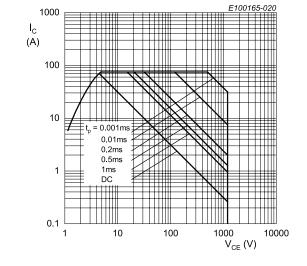
 $R_q = 10 \Omega$; $V_{GE} = 15V/0V$; $T_i = 175 °C$;

Fig. 17. Typical switching energy losses as a function

V_{CE} = 600 V; inductive load

of collector current





 I_{C} = 25 A; V_{GE} = 15V/0V; R_{g} = 10 $\Omega;$ V_{CE} = 600 V; inductive load

Fig. 20. Forward bias safe operating area

Fig. 19. Typical switching energy losses as a function of junction temperature

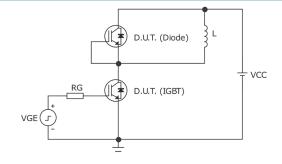


Fig. 21. Test circuit for inductive load switching

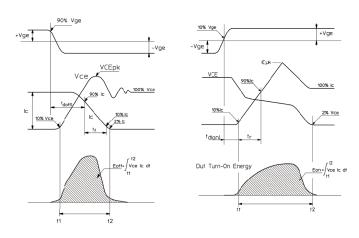
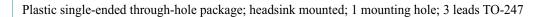
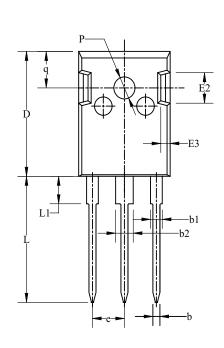


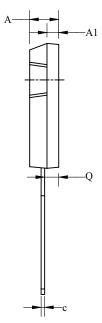
Fig. 22. Definition of switching times and losses

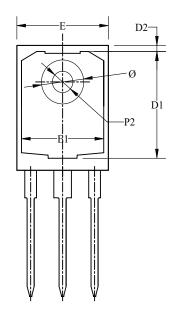
12. Package outline



TO247







Dim	All Dim	ensions in M	illimeters
Dilli	Min	Тур	Max
A	4.70	4.95	5.20
A1	1.90	2.00	2.10
b	1.00	1.20	1.40
b1	1.80	2.00	2.20
b2	2.80	3.00	3.20
с	0.50	0.60	0.70
D	20.30	20.45	20.60
D1	17.28	17.48	17.68
D2	0.80	1.00	1.20
Е	15.45	15.60	15.75
E1	13.82	14.02	14.22
E2	4.80	5.00	5.20
E3	1.40	1.60	1.80
e		5.45 BSC	
L	20.40	20.65	20.90
L1	4.25	4.50	4.75
P2	3.40	3.50	3.60
P	3.50	3.60	3.70
Q	2.20	2.40	2.60
q	5.78	5.98	6.18
Ø	7.10	7.19	7.30

IGRT

13. Legal information

Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
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- Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions".
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